

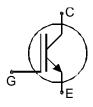
# IGBT Chip in NPT-technology

## FEATURES:

- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

## This chip is used for:

- DuoPack SGP04N60
- Applications:
- drives



Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code
SIGC05T60SNC	600V	4A	2.29 x 2.29 mm <sup>2</sup>	sawn on foil	Q67041-A3001

## MECHANICAL PARAMETER:

Raster size	2.29 x 2.29			
Area total / active	5.2 / 3.2			
Emitter pad size	1.38 x 0.93			
Gate pad size	0.7 x 0.5			
Thickness	100	μm		
Wafer size	150	mm		
Flat position	180	deg		
Max.possible chips per wafer	2990			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	Al,≤500µm			
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



## **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, Tj=25 °C	V <sub>CE</sub>	600	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	12	А
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55 +150	°C

<sup>1)</sup> depending on thermal properties of assembly

**STATIC CHARACTERISTICS** (tested on chip),  $T_i=25$  °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	V <sub>GE</sub> =0V, I <sub>C</sub> =500µA	600			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =4A	1.6	2	2.5	V
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	$I_C$ =200µA, $V_{GE}$ = $V_{CE}$	3	4	5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =600V, V <sub>GE</sub> =0V			25	μA
Gate-emitter leakage current	I <sub>GES</sub>	$V_{CE}$ =0V, $V_{GE}$ =20V			120	nA

## DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
Falameter	Symbol	Conditions	min.	typ.	max.	
Input capacitance	Ciss	$V_{CE}=25V$	-	264	317	pF
Output capacitance	Coss	$V_{GE}=0V$	-	29	35	
Reverse transfer capacitance	Crss	f=1MHz	-	17	21	

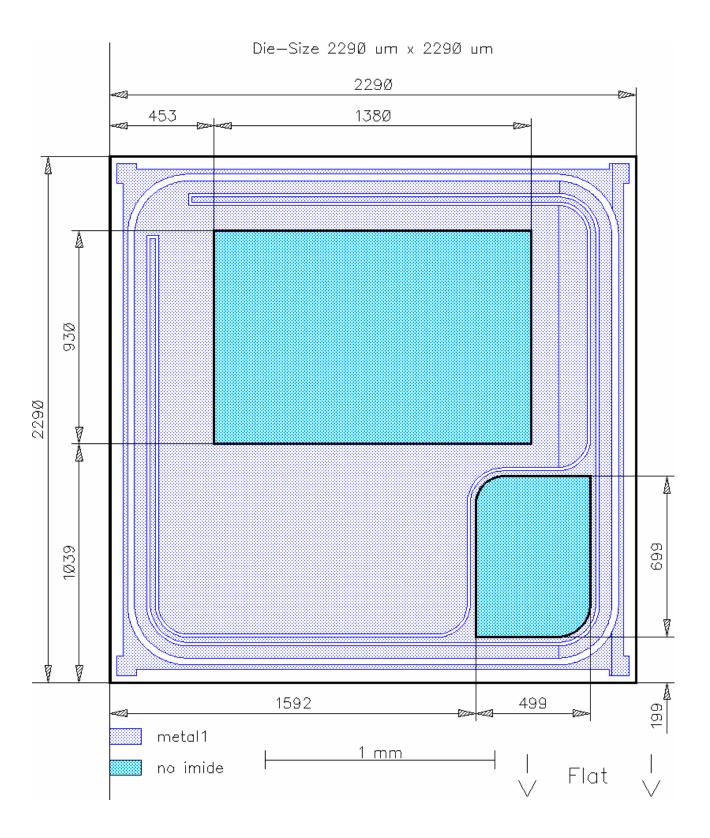
## **SWITCHING CHARACTERISTICS** (tested at component), Inductive Load:

Parameter	Symbol	Conditions <sup>2)</sup>	Value			Unit
			min.	typ.	max.	Onic
Turn-on delay time	t <sub>d(on)</sub>	$T_{j}=150 \circ C$ $V_{CC}=400 V$ $I_{C}=4A$	-	22	26	ns
Rise time	<i>t</i> r	$I_{\rm C}=400$ V	-	16	19	
Turn-off delay time	$t_{d(off)}$	V <sub>GE</sub> =+15/0V R <sub>G</sub> =67Ω	-	264	317	
Fall time	t <sub>f</sub>	116-0122	-	104	125	

<sup>2)</sup> switching conditions different to 600V LowLoss, under comparable switching conditions 40% faster turnoff than LowLoss. Values also influenced by parasitic L- and C- in measurement and package.



## CHIP DRAWING:





## FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

SGP04N60

Package:TO220

### Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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